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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	Coldfire V2
Core Size	32-Bit Single-Core
Speed	80MHz
Connectivity	I ² C, SPI, UART/USART, USB OTG
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	63
Program Memory Size	128KB (128K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	16K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 3.6V
Data Converters	A/D 8x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	100-LQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mcf52211caf80

Table of Contents

1	Family Configurations	3	2.4	Flash Memory Characteristics	29
1.1	Block Diagram	3	2.5	EzPort Electrical Specifications	30
1.2	Features	4	2.6	ESD Protection	31
1.3	Reset Signals	19	2.7	DC Electrical Specifications	31
1.4	PLL and Clock Signals	20	2.8	Clock Source Electrical Specifications	32
1.5	Mode Selection	20	2.9	USB Operation	33
1.6	External Interrupt Signals	21	2.10	General Purpose I/O Timing	33
1.7	Queued Serial Peripheral Interface (QSPI)	21	2.11	Reset Timing	34
1.8	USB On-the-Go	21	2.12	I ² C Input/Output Timing Specifications	35
1.9	I ² C I/O Signals	21	2.13	Analog-to-Digital Converter (ADC) Parameters	36
1.10	UART Module Signals	22	2.14	Equivalent Circuit for ADC Inputs	37
1.11	DMA Timer Signals	22	2.15	DMA Timers Timing Specifications	38
1.12	ADC Signals	22	2.16	QSPI Electrical Specifications	38
1.13	General Purpose Timer Signals	23	2.17	JTAG and Boundary Scan Timing	38
1.14	Pulse Width Modulator Signals	23	2.18	Debug AC Timing Specifications	41
1.15	Debug Support Signals	23	3	Mechanical Outline Drawings	42
1.16	EzPort Signal Descriptions	24	3.1	64-pin LQFP Package	43
1.17	Power and Ground Pins	25	3.2	64 QFN Package	46
2	Electrical Characteristics	26	3.3	81 MAPBGA Package	50
2.1	Maximum Ratings	26	3.4	100-pin LQFP Package	52
2.2	Current Consumption	27	4	Revision History	54
2.3	Thermal Characteristics	28			

1.2 Features

1.2.1 Feature Overview

The MCF52211 family includes the following features:

- Version 2 ColdFire variable-length RISC processor core
 - Static operation
 - 32-bit address and data paths on-chip
 - Up to 80 MHz processor core frequency
 - 40 MHz and 33 MHz off-platform bus frequency
 - Sixteen general-purpose, 32-bit data and address registers
 - Implements ColdFire ISA_A with extensions to support the user stack pointer register and four new instructions for improved bit processing (ISA_A+)
 - Multiply-Accumulate (MAC) unit with 32-bit accumulator to support $16 \times 16 \rightarrow 32$ or $32 \times 32 \rightarrow 32$ operations
- System debug support
 - Real-time trace for determining dynamic execution path
 - Background debug mode (BDM) for in-circuit debugging (DEBUG_B+)
 - Real-time debug support, with six hardware breakpoints (4 PC, 1 address and 1 data) configurable into a 1- or 2-level trigger
- On-chip memories
 - Up to 16-Kbyte dual-ported SRAM on CPU internal bus, supporting core and DMA access with standby power supply support
 - Up to 128 Kbytes of interleaved flash memory supporting 2-1-1-1 accesses
- Power management
 - Fully static operation with processor sleep and whole chip stop modes
 - Rapid response to interrupts from the low-power sleep mode (wake-up feature)
 - Clock enable/disable for each peripheral when not used (except backup watchdog timer)
 - Software controlled disable of external clock output for low-power consumption
- Universal Serial Bus On-The-Go (USB OTG) dual-mode host and device controller
 - Full-speed / low-speed host controller
 - USB 1.1 and 2.0 compliant full-speed / low speed device controller
 - 16 bidirectional end points
 - DMA or FIFO data stream interfaces
 - Low power consumption
 - OTG protocol logic
- Three universal asynchronous/synchronous receiver transmitters (UARTs)
 - 16-bit divider for clock generation
 - Interrupt control logic with maskable interrupts
 - DMA support
 - Data formats can be 5, 6, 7 or 8 bits with even, odd, or no parity
 - Up to two stop bits in 1/16 increments
 - Error-detection capabilities
 - Modem support includes request-to-send (RTS) and clear-to-send (CTS) lines for two UARTs
 - Transmit and receive FIFO buffers
- Two I²C modules

Family Configurations

- Two periodic interrupt timers (PITs)
 - 16-bit counter
 - Selectable as free running or count down
- Real-Time Clock (RTC)
 - Maintains system time-of-day clock
 - Provides stopwatch and alarm interrupt functions
- Software watchdog timer
 - 32-bit counter
 - Low-power mode support
- Backup watchdog timer (BWT)
 - Independent timer that can be used to help software recover from runaway code
 - 16-bit counter
 - Low-power mode support
- Clock generation features
 - Crystal, on-chip trimmed relaxation oscillator, or external oscillator reference options
 - Trimmed relaxation oscillator
 - Pre-divider capable of dividing the clock source frequency into the PLL reference frequency range
 - System can be clocked from PLL or directly from crystal oscillator or relaxation oscillator
 - Low power modes supported
 - 2^n ($0 \leq n \leq 15$) low-power divider for extremely low frequency operation
- Interrupt controller
 - Uniquely programmable vectors for all interrupt sources
 - Fully programmable level and priority for all peripheral interrupt sources
 - Seven external interrupt signals with fixed level and priority
 - Unique vector number for each interrupt source
 - Ability to mask any individual interrupt source or all interrupt sources (global mask-all)
 - Support for hardware and software interrupt acknowledge (IACK) cycles
 - Combinatorial path to provide wake-up from low-power modes
- DMA controller
 - Four fully programmable channels
 - Dual-address transfer support with 8-, 16-, and 32-bit data capability, along with support for 16-byte (4×32-bit) burst transfers
 - Source/destination address pointers that can increment or remain constant
 - 24-bit byte transfer counter per channel
 - Auto-alignment transfers supported for efficient block movement
 - Bursting and cycle-steal support
 - Software-programmable DMA requests for the UARTs (3) and 32-bit timers (4)
- Reset
 - Separate reset in and reset out signals
 - Seven sources of reset:
 - Power-on reset (POR)
 - External
 - Software
 - Watchdog
 - Loss of clock / loss of lock

1.2.7 USB On-The-Go Controller

The device includes a Universal Serial Bus On-The-Go (USB OTG) dual-mode controller. USB is a popular standard for connecting peripherals and portable consumer electronic devices such as digital cameras and handheld computers to host PCs. The OTG supplement to the USB specification extends USB to peer-to-peer application, enabling devices to connect directly to each other without the need for a PC. The dual-mode controller on the device can act as a USB OTG host and as a USB device. It also supports full-speed and low-speed modes.

1.2.8 UARTs

The device has three full-duplex UARTs that function independently. The three UARTs can be clocked by the system bus clock, eliminating the need for an external clock source. On smaller packages, the third UART is multiplexed with other digital I/O functions.

1.2.9 I²C Bus

The processor includes two I²C modules. The I²C bus is an industry-standard, two-wire, bidirectional serial bus that provides a simple, efficient method of data exchange and minimizes the interconnection between devices. This bus is suitable for applications requiring occasional communications over a short distance between many devices.

1.2.10 QSPI

The queued serial peripheral interface (QSPI) provides a synchronous serial peripheral interface with queued transfer capability. It allows up to 16 transfers to be queued at once, minimizing the need for CPU intervention between transfers.

1.2.11 Fast ADC

The fast ADC consists of an eight-channel input select multiplexer and two independent sample and hold (S/H) circuits feeding separate 12-bit ADCs. The two separate converters store their results in accessible buffers for further processing.

The ADC can be configured to perform a single scan and halt, a scan when triggered, or a programmed scan sequence repeatedly until manually stopped.

The ADC can be configured for sequential or simultaneous conversion. When configured for sequential conversions, up to eight channels can be sampled and stored in any order specified by the channel list register. Both ADCs may be required during a scan, depending on the inputs to be sampled.

During a simultaneous conversion, both S/H circuits are used to capture two different channels at the same time. This configuration requires that a single channel may not be sampled by both S/H circuits simultaneously.

Optional interrupts can be generated at the end of the scan sequence if a channel is out of range (measures below the low threshold limit or above the high threshold limit set in the limit registers) or at several different zero crossing conditions.

1.2.12 DMA Timers (DTIM0–DTIM3)

There are four independent, DMA transfer capable 32-bit timers (DTIM0, DTIM1, DTIM2, and DTIM3) on the device. Each module incorporates a 32-bit timer with a separate register set for configuration and control. The timers can be configured to operate from the system clock or from an external clock source using one of the DTIN_n signals. If the system clock is selected, it can be divided by 16 or 1. The input clock is further divided by a user-programmable 8-bit prescaler that clocks the actual timer counter register (TCR_n). Each of these timers can be configured for input capture or reference (output) compare mode. Timer events may optionally cause interrupt requests or DMA transfers.

1.2.20 Interrupt Controller (INTC)

The device has a single interrupt controller that supports up to 63 interrupt sources. There are 56 programmable sources, 49 of which are assigned to unique peripheral interrupt requests. The remaining seven sources are unassigned and may be used for software interrupt requests.

1.2.21 DMA Controller

The direct memory access (DMA) controller provides an efficient way to move blocks of data with minimal processor intervention. It has four channels that allow byte, word, longword, or 16-byte burst line transfers. These transfers are triggered by software explicitly setting a DCRn[START] bit or by the occurrence of certain UART or DMA timer events.

1.2.22 Reset

The reset controller determines the source of reset, asserts the appropriate reset signals to the system, and keeps track of what caused the last reset. There are seven sources of reset:

- External reset input
- Power-on reset (POR)
- Watchdog timer
- Phase locked-loop (PLL) loss of lock / loss of clock
- Software
- Low-voltage detector (LVD)
- JTAG

Control of the LVD and its associated reset and interrupt are managed by the reset controller. Other registers provide status flags indicating the last source of reset and a control bit for software assertion of the RSTO pin.

1.2.23 GPIO

Nearly all pins on the device have general purpose I/O capability and are grouped into 8-bit ports. Some ports do not use all eight bits. Each port has registers that configure, monitor, and control the port pin.

1.2.24 Part Numbers and Packaging

This product is RoHS-compliant. Refer to the product page at freescale.com or contact your sales office for up-to-date RoHS information.

Table 2. Orderable Part Number Summary

Freescall Part Number	Description	Speed (MHz)	Flash/SRAM (Kbytes)	Package	Temp range (°C)
MCF52210CAE66	MCF52210 Microcontroller, 2 UARTs	66	64 / 16	64 LQFP	-40 to +85
MCF52210CEP66	MCF52210 Microcontroller, 2 UARTs	66	64 / 16	64 QFN	-40 to +85
MCF52210CVM66	MCF52210 Microcontroller, 2 UARTs	66	64 / 16	81 MAPBGA	-40 to +85
MCF52210CVM80	MCF52210 Microcontroller, 2 UARTs	80	64 / 16	81 MAPBGA	-40 to +85
MCF52211CAE66	MCF52211 Microcontroller, 2 UARTs	66	128 / 16	64 LQFP	-40 to +85
MCF52211CAF80	MCF52211 Microcontroller, 3 UARTs	80	128 / 16	100 LQFP	-40 to +85
MCF52211CEP66	MCF52211 Microcontroller, 2 UARTs	66	128 / 16	64 QFN	-40 to +85

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength / Control ¹	Slew Rate / Control ¹	Pull-up / Pull-down ²	Pin on 100 LQFP	Pin on 81 MAPBGA	Pin on 64 LQFP/QFN
Interrupts	$\overline{\text{IRQ7}}$	—	—	GPIO	Low	FAST	—	95	C4	58
	$\overline{\text{IRQ6}}$	—	—	GPIO	Low	FAST	—	94	B4	—
	$\overline{\text{IRQ5}}$	—	—	GPIO	Low	FAST	—	91	A4	—
	$\overline{\text{IRQ4}}$	—	—	GPIO	Low	FAST	—	90	C5	57
	$\overline{\text{IRQ3}}$	—	—	GPIO	Low	FAST	—	89	A5	—
	$\overline{\text{IRQ2}}$	—	—	GPIO	Low	FAST	—	88	B5	—
	$\overline{\text{IRQ1}}$	SYNCA	USB_ALT_CLK	GPIO	High	FAST	pull-up ⁴	87	C6	56
JTAG/BDM	JTAG_EN	—	—	—	N/A	N/A	pull-down	26	J2	17
	TCLK/ PSTCLK	CLKOUT	—	—	High	FAST	pull-up ⁵	64	C7	44
	TDI/DSI	—	—	—	N/A	N/A	pull-up ⁵	79	B7	50
	TDO/DSO	—	—	—	High	FAST	—	80	A7	51
	$\overline{\text{TMS}}$ / $\overline{\text{BKPT}}$	—	—	—	N/A	N/A	pull-up ⁵	76	A8	49
	$\overline{\text{TRST}}$ / $\overline{\text{DSCLK}}$	—	—	—	N/A	N/A	pull-up ⁵	85	B6	54
Mode Selection ⁶	CLKMOD0	—	—	—	N/A	N/A	pull-down ⁶	40	G5	24
	CLKMOD1	—	—	—	N/A	N/A	pull-down ⁶	39	H5	—
	$\overline{\text{RCON}}$ / EZPCS	—	—	—	N/A	N/A	pull-up	21	G3	16

1.3 Reset Signals

Table 4 describes signals used to reset the chip or as a reset indication.

Table 4. Reset Signals

Signal Name	Abbreviation	Function	I/O
Reset In	$\overline{\text{RSTI}}$	Primary reset input to the device. Asserting $\overline{\text{RSTI}}$ for at least 8 CPU clock cycles immediately resets the CPU and peripherals.	I
Reset Out	$\overline{\text{RSTO}}$	Driven low for 1024 CPU clocks after the reset source has deasserted.	O

1.4 PLL and Clock Signals

Table 5 describes signals used to support the on-chip clock generation circuitry.

Table 5. PLL and Clock Signals

Signal Name	Abbreviation	Function	I/O
External Clock In	EXTAL	Crystal oscillator or external clock input except when the on-chip relaxation oscillator is used.	I
Crystal	XTAL	Crystal oscillator output except when CLKMOD0=0, then sampled as part of the clock mode selection mechanism.	O
Clock Out	CLKOUT	This output signal reflects the internal system clock.	O

1.5 Mode Selection

Table 6 describes signals used in mode selection; Table 7 describes the particular clocking modes.

Table 6. Mode Selection Signals

Signal Name	Abbreviation	Function	I/O
Clock Mode Selection	CLKMOD[1:0]	Selects the clock boot mode.	I
Reset Configuration	RCON	The Serial Flash Programming mode is entered by asserting the $\overline{\text{RCON}}$ pin (with the TEST pin negated) as the chip comes out of reset. During this mode, the EzPort has access to the flash memory which can be programmed from an external device.	
Test	TEST	Reserved for factory testing only and in normal modes of operation should be connected to VSS to prevent unintentional activation of test functions.	I

Table 7. Clocking Modes

CLKMOD[1:0]	XTAL	Configure the clock mode.
00	0	PLL disabled, clock driven by external oscillator
00	1	PLL disabled, clock driven by on-chip oscillator

Table 10. I²C I/O Signals

Signal Name	Abbreviation	Function	I/O
Serial Clock	SCL _n	Open-drain clock signal for the for the I ² C interface. When the bus is in master mode, this clock is driven by the I ² C module; when the bus is in slave mode, this clock becomes the clock input.	I/O
Serial Data	SDA _n	Open-drain signal that serves as the data input/output for the I ² C interface.	I/O

1.10 UART Module Signals

Table 11 describes the UART module signals.

Table 11. UART Module Signals

Signal Name	Abbreviation	Function	I/O
Transmit Serial Data Output	UTXD _n	Transmitter serial data outputs for the UART modules. The output is held high (mark condition) when the transmitter is disabled, idle, or in the local loopback mode. Data is shifted out, LSB first, on this pin at the falling edge of the serial clock source.	O
Receive Serial Data Input	URXD _n	Receiver serial data inputs for the UART modules. Data is received on this pin LSB first. When the UART clock is stopped for power-down mode, any transition on this pin restarts the clock.	I
Clear-to-Send	$\overline{\text{UCTS}}_n$	Indication to the UART modules that they can begin data transmission.	I
Request-to-Send	$\overline{\text{URTS}}_n$	Automatic request-to-send outputs from the UART modules. This signal can also be configured to be asserted and negated as a function of the RxFIFO level.	O

1.11 DMA Timer Signals

Table 12 describes the signals of the four DMA timer modules.

Table 12. DMA Timer Signals

Signal Name	Abbreviation	Function	I/O
DMA Timer Input	DTIN	Event input to the DMA timer modules.	I
DMA Timer Output	DTOUT	Programmable output from the DMA timer modules.	O

Table 17. EzPort Signal Descriptions

Signal Name	Abbreviation	Function	I/O
EzPort Clock	EZPCK	Shift clock for EzPort transfers.	I
EzPort Chip Select	EZPCS	Chip select for signalling the start and end of serial transfers.	I
EzPort Serial Data In	EZPD	EZPD is sampled on the rising edge of EZPCK.	I
EzPort Serial Data Out	EZPQ	EZPQ transitions on the falling edge of EZPCK.	O

1.17 Power and Ground Pins

The pins described in [Table 18](#) provide system power and ground to the chip. Multiple pins are provided for adequate current capability. All power supply pins must have adequate bypass capacitance for high-frequency noise suppression.

Table 18. Power and Ground Pins

Signal Name	Abbreviation	Function
PLL Analog Supply	VDDPLL, VSSPLL	Dedicated power supply signals to isolate the sensitive PLL analog circuitry from the normal levels of noise present on the digital power supply.
Positive Supply	VDD	These pins supply positive power to the core logic.
Ground	VSS	This pin is the negative supply (ground) to the chip.

2 Electrical Characteristics

This section contains electrical specification tables and reference timing diagrams for the microcontroller unit, including detailed information on power considerations, DC/AC electrical characteristics, and AC timing specifications.

The electrical specifications are preliminary and are from previous designs or design simulations. These specifications may not be fully tested or guaranteed at this early stage of the product life cycle. These specifications will, however, be met for production silicon. Finalized specifications will be published after complete characterization and device qualifications have been completed.

NOTE

The parameters specified in this data sheet supersede any values found in the module specifications.

2.1 Maximum Ratings

Table 19. Absolute Maximum Ratings^{1, 2}

Rating	Symbol	Value	Unit
Supply voltage	V_{DD}	−0.3 to +4.0	V
Clock synthesizer supply voltage	V_{DDPLL}	−0.3 to +4.0	V
RAM standby supply voltage	V_{STBY}	+1.8 to 3.5	V
USB standby supply voltage	V_{DDUSB}	−0.3 to +4.0	V
Digital input voltage ³	V_{IN}	−0.3 to +4.0	V
EXTAL pin voltage	V_{EXTAL}	0 to 3.3	V
XTAL pin voltage	V_{XTAL}	0 to 3.3	V
Instantaneous maximum current Single pin limit (applies to all pins) ^{4, 5}	I_{DD}	25	mA
Operating temperature range (packaged)	T_A ($T_L - T_H$)	−40 to 85 or 0 to 70 ⁶	°C
Storage temperature range	T_{stg}	−65 to 150	°C

¹ Functional operating conditions are given in DC Electrical Specifications. Absolute Maximum Ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond those listed may affect device reliability or cause permanent damage to the device.

² This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (V_{SS} or V_{DD}).

³ Input must be current limited to the I_{DD} value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger of the two values.

⁴ All functional non-supply pins are internally clamped to V_{SS} and V_{DD} .

⁵ The power supply must maintain regulation within operating V_{DD} range during instantaneous and operating maximum current conditions. If positive injection current ($V_{in} > V_{DD}$) is greater than I_{DD} , the injection current may flow out of V_{DD} and could result in the external power supply going out of regulation. Ensure that the external V_{DD} load shunts current greater than maximum injection current. This is the greatest risk when the MCU is not consuming power (e.g., no clock).

⁶ Depending on the packaging; see the orderable part number summary.

Table 24. SGFM Flash Module Life Characteristics

($V_{DD} = 3.0$ to 3.6 V)

Parameter	Symbol	Value	Unit
Maximum number of guaranteed program/erase cycles ¹ before failure	P/E	10,000 ²	Cycles
Data retention at average operating temperature of 85°C	Retention	10	Years

¹ A program/erase cycle is defined as switching the bits from 1 → 0 → 1.

² Reprogramming of a flash memory array block prior to erase is not required.

2.5 EzPort Electrical Specifications

Table 25. EzPort Electrical Specifications

Name	Characteristic	Min	Max	Unit
EP1	EPCK frequency of operation (all commands except READ)	—	$f_{sys} / 2$	MHz
EP1a	EPCK frequency of operation (READ command)	—	$f_{sys} / 8$	MHz
EP2	EPCS_b negation to next EPCS_b assertion	$2 \times T_{cyc}$	—	ns
EP3	EPCS_B input valid to EPCK high (setup)	5	—	ns
EP4	EPCK high to EPCS_B input invalid (hold)	5	—	ns
EP5	EPD input valid to EPCK high (setup)	2	—	ns
EP6	EPCK high to EPD input invalid (hold)	5	—	ns
EP7	EPCK low to EPQ output valid (out setup)	—	12	ns
EP8	EPCK low to EPQ output invalid (out hold)	0	—	ns
EP9	EPCS_B negation to EPQ tri-state	—	12	ns

Table 27. DC Electrical Specifications (continued)¹

Characteristic	Symbol	Min	Max	Unit
Output high voltage (high drive) $I_{OH} = -5 \text{ mA}$	V_{OH}	$V_{DD} - 0.5$	—	V
Output low voltage (high drive) $I_{OL} = 5 \text{ mA}$	V_{OL}	—	0.5	V
Output high voltage (low drive) $I_{OH} = -2 \text{ mA}$	V_{OH}	$V_{DD} - 0.5$	—	V
Output low voltage (low drive) $I_{OL} = 2 \text{ mA}$	V_{OL}	—	0.5	V
Weak internal pull Up device current, tested at V_{IL} Max. ³	I_{APU}	-10	-130	μA
Input Capacitance ⁴ • All input-only pins • All input/output (three-state) pins	C_{in}	— —	7 7	pF

¹ Refer to [Table 28](#) for additional PLL specifications.

² Only for pins: IRQ1, IRQ2, IRQ3, IRQ4, IRQ5, IRQ6, IRQ7, RSTIN_B, RCON_B, PCS0, SCK, I2C_SDA, I2C_SCL, TCLK, TRST_B, TEST

³ Refer to [Table 3](#) for pins having internal pull-up devices.

⁴ This parameter is characterized before qualification rather than 100% tested.

2.8 Clock Source Electrical Specifications

Table 28. Oscillator and PLL Electrical Specifications

(V_{DD} and $V_{DDPLL} = 2.7$ to 3.6 V , $V_{SS} = V_{SSPLL} = 0 \text{ V}$)

Characteristic	Symbol	Min	Max	Unit
Clock Source Frequency Range of EXTAL Frequency Range • Crystal • External ¹	$f_{crystal}$ f_{ext}	1 0	25.0 ² 50-80	MHz
PLL reference frequency range	f_{ref_pll}	2	10.0	MHz
System frequency ³ • External clock mode • On-chip PLL frequency	f_{sys}	0 $f_{ref} / 32$	50-80 ⁴ 50-80 ⁴	MHz
Loss of reference frequency ^{5, 7}	f_{LOR}	100	1000	kHz
Self clocked mode frequency ⁶	f_{SCM}	1	5	MHz
Crystal start-up time ^{7, 8}	t_{cst}	—	0.1	ms
EXTAL input high voltage • External reference	V_{IHEXT}	2.0	3.0 ²	V
EXTAL input low voltage • External reference	V_{ILEXT}	V_{SS}	0.8	V
PLL lock time ^{4,9}	t_{lpll}	—	500	μs
Duty cycle of reference ⁴	t_{dc}	40	60	% f_{ref}

2.12 I²C Input/Output Timing Specifications

Table 32 lists specifications for the I²C input timing parameters shown in Figure 7.

Table 32. I²C Input Timing Specifications between I2C_SCL and I2C_SDA

Num	Characteristic	Min	Max	Units
11	Start condition hold time	$2 \times t_{CYC}$	—	ns
12	Clock low period	$8 \times t_{CYC}$	—	ns
13	SCL/SDA rise time ($V_{IL} = 0.5 \text{ V}$ to $V_{IH} = 2.4 \text{ V}$)	—	1	ms
14	Data hold time	0	—	ns
15	SCL/SDA fall time ($V_{IH} = 2.4 \text{ V}$ to $V_{IL} = 0.5 \text{ V}$)	—	1	ms
16	Clock high time	$4 \times t_{CYC}$	—	ns
17	Data setup time	0	—	ns
18	Start condition setup time (for repeated start condition only)	$2 \times t_{CYC}$	—	ns
19	Stop condition setup time	$2 \times t_{CYC}$	—	ns

Table 33 lists specifications for the I²C output timing parameters shown in Figure 7.

Table 33. I²C Output Timing Specifications between I2C_SCL and I2C_SDA

Num	Characteristic	Min	Max	Units
11 ¹	Start condition hold time	$6 \times t_{CYC}$	—	ns
12 ¹	Clock low period	$10 \times t_{CYC}$	—	ns
13 ²	I2C_SCL/I2C_SDA rise time ($V_{IL} = 0.5 \text{ V}$ to $V_{IH} = 2.4 \text{ V}$)	—	—	μs
14 ¹	Data hold time	$7 \times t_{CYC}$	—	ns
15 ³	I2C_SCL/I2C_SDA fall time ($V_{IH} = 2.4 \text{ V}$ to $V_{IL} = 0.5 \text{ V}$)	—	3	ns
16 ¹	Clock high time	$10 \times t_{CYC}$	—	ns
17 ¹	Data setup time	$2 \times t_{CYC}$	—	ns
18 ¹	Start condition setup time (for repeated start condition only)	$20 \times t_{CYC}$	—	ns
19 ¹	Stop condition setup time	$10 \times t_{CYC}$	—	ns

¹ Output numbers depend on the value programmed into the IFDR; an IFDR programmed with the maximum frequency (IFDR = 0x20) results in minimum output timings as shown in Table 33. The I²C interface is designed to scale the actual data transition time to move it to the middle of the SCL low period. The actual position is affected by the prescale and division values programmed into the IFDR; however, the numbers given in Table 33 are minimum values.

² Because SCL and SDA are open-collector-type outputs, which the processor can only actively drive low, the time SCL or SDA take to reach a high level depends on external signal capacitance and pull-up resistor values.

³ Specified at a nominal 50-pF load.

Electrical Characteristics

Figure 7 shows timing for the values in Table 32 and Table 33.

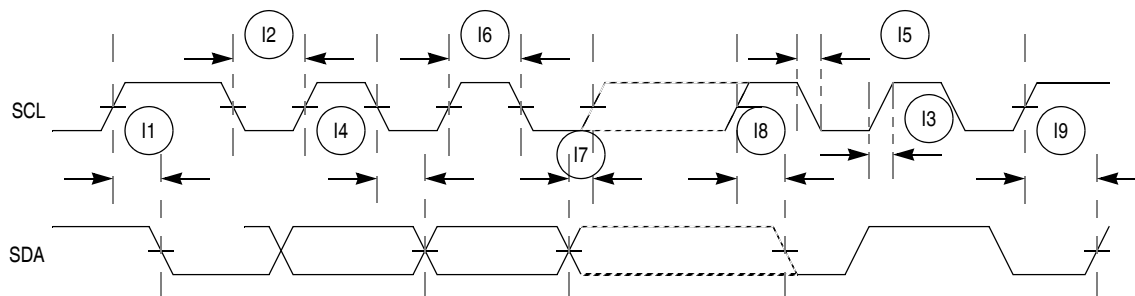


Figure 7. I²C Input/Output Timings

2.13 Analog-to-Digital Converter (ADC) Parameters

Table 34 lists specifications for the analog-to-digital converter.

Table 34. ADC Parameters¹

Name	Characteristic	Min	Typical	Max	Unit
V _{REFL}	Low reference voltage	V _{SS}	—	V _{REFH}	V
V _{REFH}	High reference voltage	V _{REFL}	—	V _{DDA}	V
V _{DDA}	ADC analog supply voltage	3.0	3.3	3.6	V
V _{ADIN}	Input voltages	V _{REFL}	—	V _{REFH}	V
RES	Resolution	12	—	12	Bits
INL	Integral non-linearity (full input signal range) ²	—	±2.5	±3	LSB ³
INL	Integral non-linearity (10% to 90% input signal range) ⁴	—	±2.5	±3	LSB
DNL	Differential non-linearity	—	-1 < DNL < +1	<+1	LSB
Monotonicity		GUARANTEED			
f _{ADIC}	ADC internal clock	0.1	—	5.0	MHz
R _{AD}	Conversion range	V _{REFL}	—	V _{REFH}	V
t _{ADPU}	ADC power-up time ⁵	—	6	13	t _{AIC} cycles ⁶
t _{REC}	Recovery from auto standby	—	0	1	t _{AIC} cycles
t _{ADC}	Conversion time	—	6	—	t _{AIC} cycles
t _{ADS}	Sample time	—	1	—	t _{AIC} cycles
C _{ADI}	Input capacitance	—	See Figure 8	—	pF
X _{IN}	Input impedance	—	See Figure 8	—	W
I _{ADI}	Input injection current ⁷ , per pin	—	—	3	mA
I _{VREFH}	V _{REFH} current	—	0	—	mA
V _{OFFSET}	Offset voltage internal reference	—	±8	±15	mV
E _{GAIN}	Gain error (transfer path)	.99	1	1.01	—
V _{OFFSET}	Offset voltage external reference	—	±3	9	mV
SNR	Signal-to-noise ratio	—	62 to 66	—	dB

2.15 DMA Timers Timing Specifications

Table 35 lists timer module AC timings.

Table 35. Timer Module AC Timing Specifications

Name	Characteristic ¹	Min	Max	Unit
T1	DTIN0 / DTIN1 / DTIN2 / DTIN3 cycle time	$3 \times t_{CYC}$	—	ns
T2	DTIN0 / DTIN1 / DTIN2 / DTIN3 pulse width	$1 \times t_{CYC}$	—	ns

¹ All timing references to CLKOUT are given to its rising edge.

2.16 QSPI Electrical Specifications

Table 36 lists QSPI timings.

Table 36. QSPI Modules AC Timing Specifications

Name	Characteristic	Min	Max	Unit
QS1	QSPI_CS[3:0] to QSPI_CLK	1	510	t_{CYC}
QS2	QSPI_CLK high to QSPI_DOUT valid	—	10	ns
QS3	QSPI_CLK high to QSPI_DOUT invalid (Output hold)	2	—	ns
QS4	QSPI_DIN to QSPI_CLK (Input setup)	9	—	ns
QS5	QSPI_DIN to QSPI_CLK (Input hold)	9	—	ns

The values in Table 36 correspond to Figure 9.

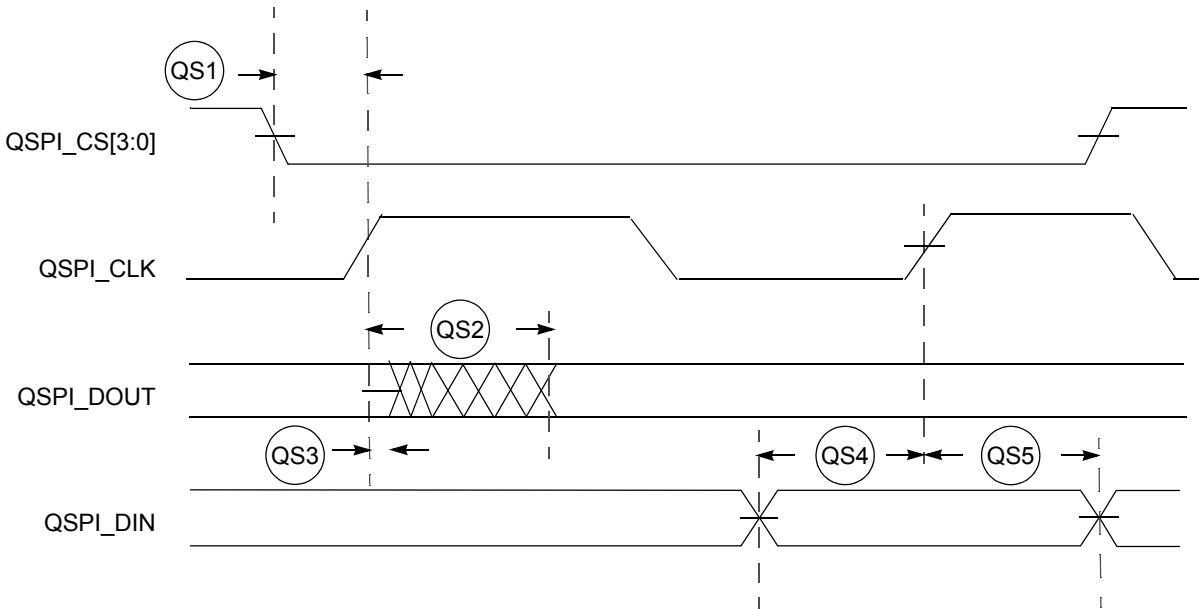
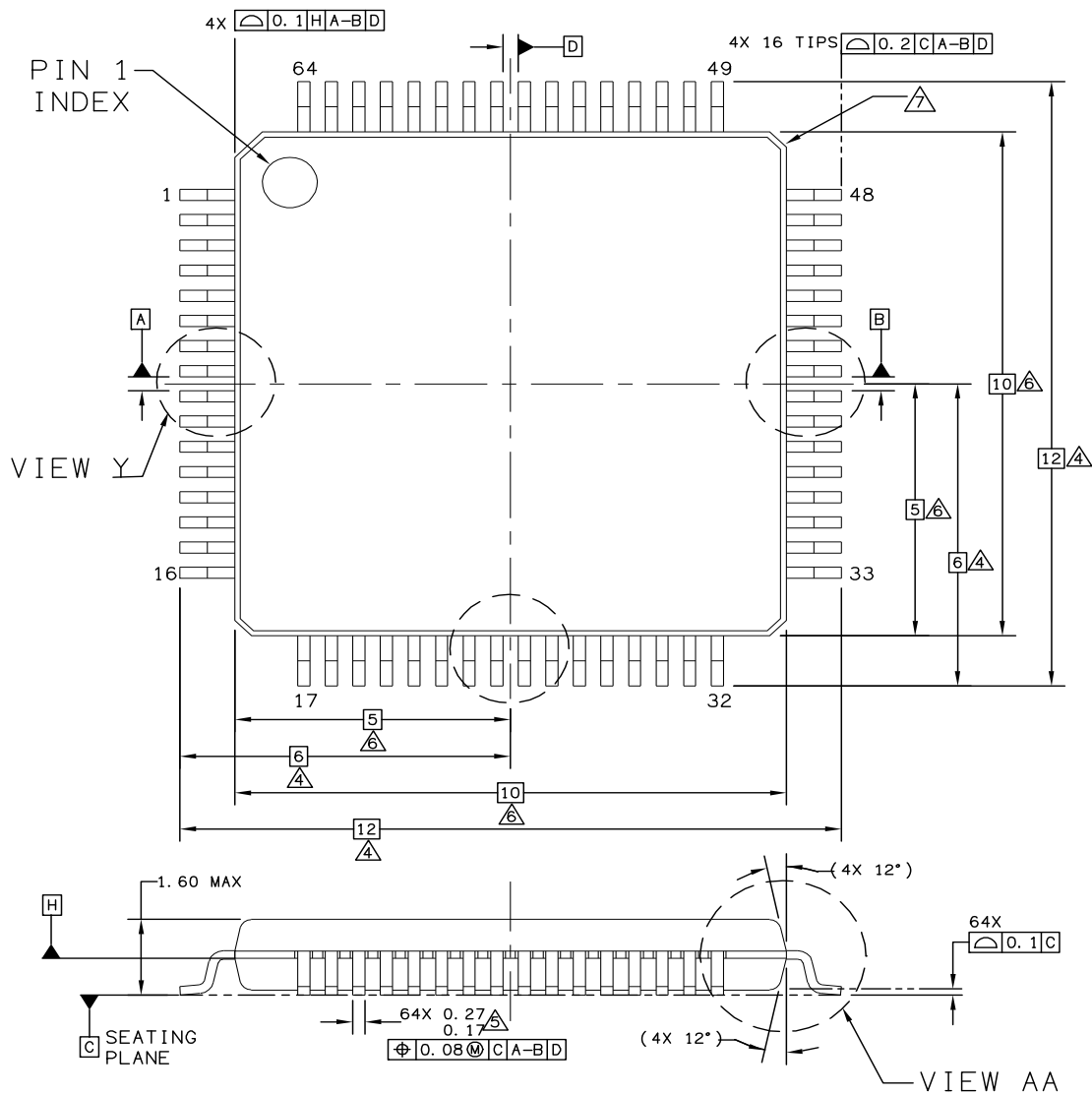


Figure 9. QSPI Timing

2.17 JTAG and Boundary Scan Timing

3.1 64-pin LQFP Package



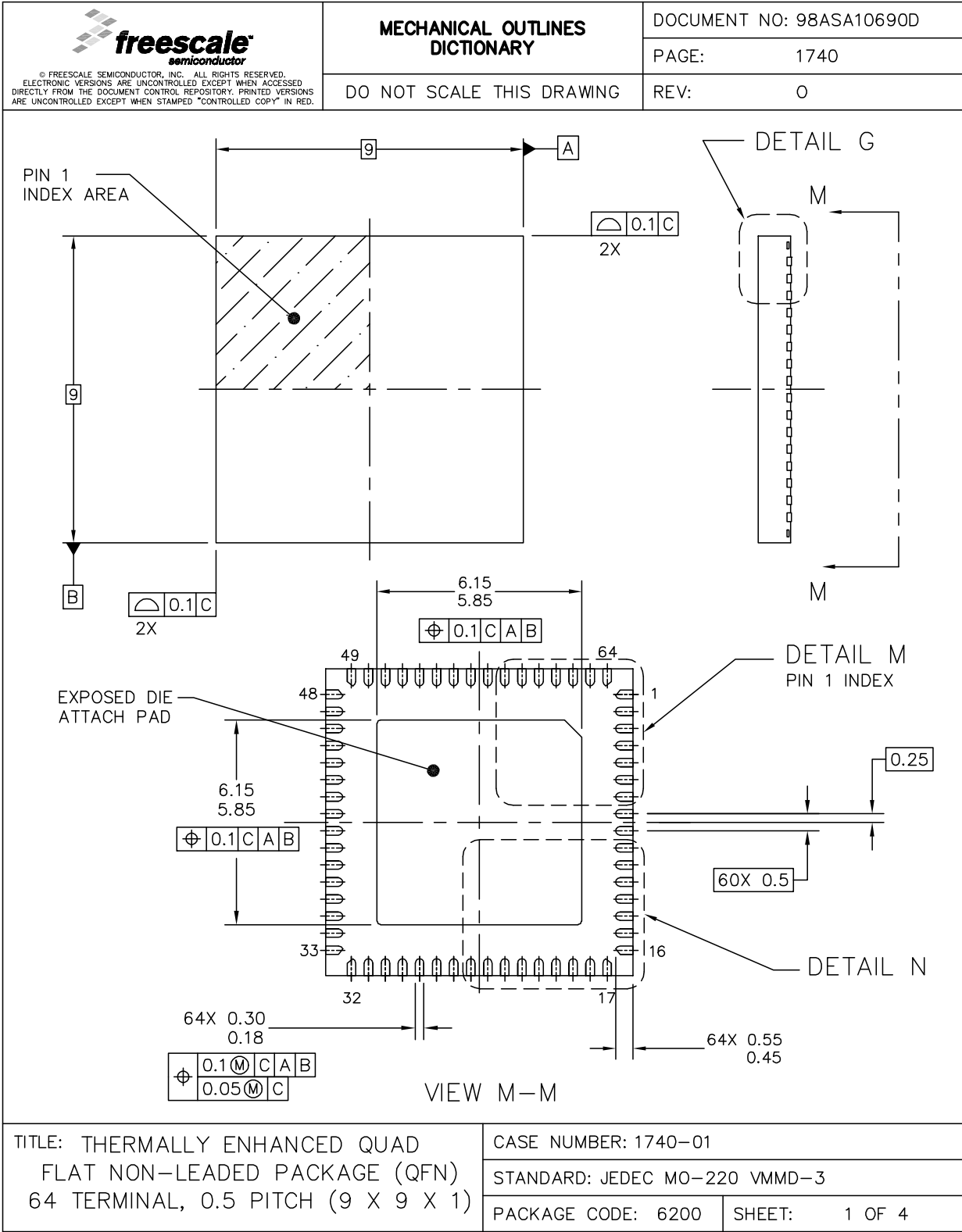
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TITLE: 64LD LQFP, 10 X 10 X 1.4 PKG, 0.5 PITCH, CASE OUTLINE	DOCUMENT NO: 98ASS23234W	REV: D	
	CASE NUMBER: 840F-02	06 APR 2005	
	STANDARD: JEDEC MS-026 BCD		

NOTES:

1. DIMENSIONS ARE IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
3. DATUMS A, B AND D TO BE DETERMINED AT DATUM PLANE H.
- △4. DIMENSIONS TO BE DETERMINED AT SEATING PLANE C.
- △5. THIS DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED THE UPPER LIMIT BY MORE THAN 0.08 mm AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSION AND ADJACENT LEAD SHALL NOT BE LESS THAN 0.07 mm.
- △6. THIS DIMENSION DOES NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25 mm PER SIDE. THIS DIMENSION IS MAXIMUM PLASTIC BODY SIZE DIMENSION INCLUDING MOLD MISMATCH.
- △7. EXACT SHAPE OF EACH CORNER IS OPTIONAL.
- △8. THESE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.1 mm AND 0.25 mm FROM THE LEAD TIP.

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	CASE NUMBER: 840F-02		06 APR 2005
	STANDARD: JEDEC MS-026 BCD		

3.2 64 QFN Package



Mechanical Outline Drawings

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			PAGE: 1740	
	DO NOT SCALE THIS DRAWING		REV: 0	
NOTES: 1. ALL DIMENSIONS ARE IN MILLIMETERS. 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994. 3. THE COMPLETE JEDEC DESIGNATOR FOR THIS PACKAGE IS: HF-PQFN. 4. COPLANARITY APPLIES TO LEADS, CORNER LEADS AND DIE ATTACH PAD. 5. MIN METAL GAP SHOULD BE 0.2MM.				
TITLE: THERMALLY ENHANCED QUAD FLAT NON-LEADED PACKAGE (QFN) 64 TERMINAL, 0.5 PITCH (9 X 9 X 1)		CASE NUMBER: 1740-01		
		STANDARD: JEDEC MO-220 VMMD-3		
		PACKAGE CODE: 6200	SHEET: 3 OF 4	

4 Revision History

Table 39. Revision History

Revision	Description
0	Initial public release.
1	• Formatting, layout, spelling, and grammar corrections. • Added information about the MCF52212 and MCF52213 devices. • Synchronized the “Pin Functions by Primary and Alternate Purpose” table in this document and the reference manual. • Added a specification for V_{DDUSB} to the “Absolute maximum ratings” table. • Added specifications for V_{LVD} and V_{LVDHYS} to the “DC electrical specifications” table. • Added the “USB Operation” section. • Changed the maximum value for $f_{sys(P/E)}$ in the “SGFM Flash Program and Erase Characteristics” table (was “66.67 or 80”, is “102.4”). • Changed the maximum value for $f_{sys(R)}$ in the “SGFM Flash Program and Erase Characteristics” table (was “66.67 or 80”, is “50–80”). • Changed the crystal start-up time in the “PLL Electrical Specifications” table (was 10 ms, is 0.1 ms). • Updated the current consumption specifications. • Updated the maximum temperature and added clarifying footnote. • Changed the absolute maximum rating for V_{STBY} (was “-0.3 to 4.0”, is “+1.8 to 3.5”). • Changed the maximum value for f_{sys} in the “PLL Electrical Specifications” table (was “66.67 or 80”, is “50–80”).
2	• Updated Clock generation features • Updated Table: Clocking Modes and added appropriate footnote • In Table: CLock Source Electrical Specifications, updated the following values: $f_{crystal}$, f_{ext}, f_{ref_pll}, EXTAL input high voltage (External reference)